

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/824,898	KUSHNICK, ERIC B.	
		Examiner	Art Unit	Page 1 of 1
		Tse Chen	2116	

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,194,928	02-2001	Heyne, Patrick	327/152
	B	US-5,471,165	11-1995	Liedberg, Nils P. A.	327/250
	C	US-6,265,924	07-2001	Desai, Chintan	327/276
	D	US-6,388,485	05-2002	Kim, Kyu-hyoun	327/161
	E	US-5,604,775	02-1997	Saitoh et al.	375/376
	F	US-6,259,330	07-2001	Arai, Kouji	331/57
	G	US-6,100,735	08-2000	Lu, Crist Y.	327/158
	H	US-5,670,904	09-1997	Moloney et al.	327/277
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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